Search Notes

Application/Control No.	•	Applicant(s)/Patent under Reexamination
09/904,486		PARKKINEN ET AL.

Examiner

PARKKINEN ET AL.

Art Unit

2668 Hanh Nguyen

	SEAR	CHED	
Class	Subclass	Date	Examiner
370	535	3/2/2006	HN
	536		
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	538		
	235		
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	230		
	391		
348	401		
	415		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
370	538				
370	235				
348	415				

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